Search	<b>Notes</b>	(contin	nued

Application/Control No.	Applicant(s)/Patent under Reexamination
10/707,826	CHEN ET AL.
Examiner	Art Unit
Mai-Huong Tran	2818

SEARCHED				
Class	Subclass	Date	Examiner	
257	314	4/22/2005	MT	
	315			
	316			
	321			
	438			
438	260			
	267			
	254			
	257			
	253			
	259			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
257	315	4/22/2005	МТ	
438	260			
	267			
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	SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR	
EAST	4/22/2005	MT	
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